## Notice of References Cited Application/Control No. 10/769,684 Examiner Leon J. Harper Applicant(s)/Patent Under Reexamination BONILLA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0039745	02-2004	Evans et al.	707/100
	В	US-			
	С	US-			
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	Е	US-			
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